

**Notice of References Cited**

Application/Control No.

09/943,450

Applicant(s)/Patent Under  
Reexamination  
HOHKITA ET AL.

Examiner

Thai-Ba Trieu

Art Unit

3748

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,397,820 B1	06-2002	Novak et al.	60/274
	B	US-6,390,081 B1	05-2002	Novak et al.	60/277
	C	US-4,705,001	11-1987	Danno et al.	123/339.23
	D	US-4,437,311	03-1984	Iwamoto et al.	60/602
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 56018026 A	02-1981	Japan	NOHIRA et al.	F02B 37/12
	O	JP 05240193 A	09-1993	Japan	YOSHIKAWA et al.	F04D 29/42
	P	JP 02259224 A	10-1990	Japan	KAGEYAMA, ETSUO	F01N 03/24
	Q	JP 07332072 A	12-1995	Japan	KIBE, KAZUYA	F01N 03/24
	R	FR 2 650 860 A	02-1991	France	Pierre Guimbretiere	60/602
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.